

<b>Notice of References Cited</b>	Application/Control No. 10/581,231		Applicant(s)/Patent Under Reexamination JIANG ET AL.	
	Examiner HOANG-CHUONG Q. VU		Art Unit 2619	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,848,065 A	12-1998	Gorshe et al.	370/376
*	B	US-6,487,223 B1	11-2002	Tanonaka, Kouji	370/539
*	C	US-2003/0002505 A1	01-2003	Hoch et al.	370/392
*	D	US-2003/0058897 A1	03-2003	Yamamoto, Kanta	370/535
*	E	US-2004/0076166 A1	04-2004	Patenaude, Jean-Marc Guy	370/401
*	F	US-6,765,928 B1	07-2004	Sethuram et al.	370/476
*	G	US-6,778,529 B1	08-2004	Field et al.	370/353
*	H	US-6,798,779 B1	09-2004	Shimbashi et al.	370/395.1
*	I	US-6,891,862 B1	05-2005	Brady et al.	370/539
*	J	US-7,257,117 B2	08-2007	Roberts et al.	370/392
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	X	

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